

8A, 800V N-CHANNEL MOSFET

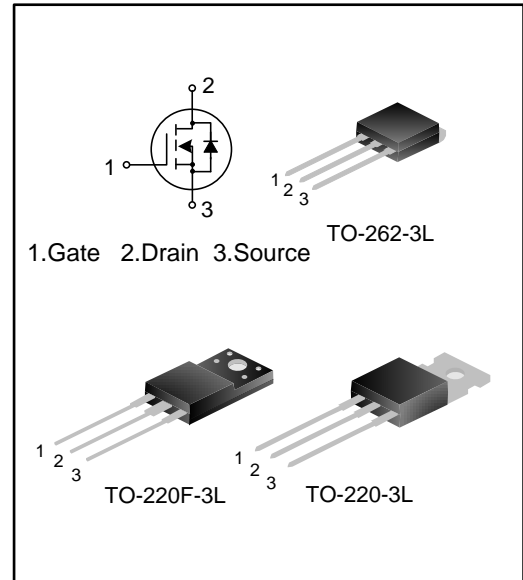
GENERAL DESCRIPTION

SVF8N80T/F/K is an N-channel enhancement mode power MOS field effect transistor which is produced using Silan proprietary F-Cell™ structure VDMOS technology. The improved planar stripe cell and the improved guard ring terminal have been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode.

These devices are widely used in AC-DC power suppliers, DC-DC converters and H-bridge PWM motor drivers.

FEATURES

- ◆ 8A,800V, $R_{DS(on)(typ.)}=1.42\Omega@V_{GS}=10V$
- ◆ Low gate charge
- ◆ Low Crss
- ◆ Fast switching
- ◆ Improved dv/dt capability



ORDERING INFORMATION

Part No.	Package	Marking	Hazardous Substance Control	Packing Type
SVF8N80T	TO-220-3L	SVF8N80T	Pb free	Tube
SVF8N80F	TO-220F-3L	SVF8N80F	Pb free	Tube
SVF8N80K	TO-262-3L	SVF8N80K	Pb free	Tube

ABSOLUTE MAXIMUM RATINGS (T_C=25°C UNLESS OTHERWISE NOTED)

Characteristics	Symbol	Ratings			Unit
		SVF8N80T	SVF8N80F	SVF8N80K	
Drain-Source Voltage	V _{DS}	800			V
Gate-Source Voltage	V _{GS}	±30			V
Drain Current	I _D	T _C = 25°C			A
		T _C = 100°C			
Drain Current Pulsed	I _{DM}	32.0			A
Power Dissipation(T _C =25°C) -Derate above 25°C	P _D	178	57	165	W
		1.42	0.46	1.32	W/°C
Single Pulsed Avalanche Energy (Note 1)	E _{AS}	534			mJ
Operation Junction Temperature Range	T _J	-55~+150			°C
Storage Temperature Range	T _{stg}	-55~+150			°C

THERMAL CHARACTERISTICS

Characteristics	Symbol	Ratings			Unit
		SVF8N80T	SVF8N80F	SVF8N80K	
Thermal Resistance, Junction-to-Case	R _{θJC}	0.70	2.19	0.76	°C/W
Thermal Resistance, Junction-to-Ambient	R _{θJA}	62.5	62.5	62.5	°C/W

ELECTRICAL CHARACTERISTICS (T_C=25°C UNLESS OTHERWISE NOTED)

Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Drain -Source Breakdown Voltage	B _{VDS}	V _{GS} =0V, I _D =250μA	800	--	--	V
Drain-Source Leakage Current	I _{DSS}	V _{DS} =800V, V _{GS} =0V	--	--	1.0	μA
Gate-Source Leakage Current	I _{GSS}	V _{GS} =±30V, V _{DS} =0V	--	--	±100	nA
Gate Threshold Voltage	V _{GS(th)}	V _{GS} = V _{DS} , I _D =250μA	2.0	--	4.0	V
Static Drain- Source On State Resistance	R _{DS(on)}	V _{GS} =10V, I _D =4.0A	--	1.42	1.6	Ω
Input Capacitance	C _{iss}	V _{DS} =25V, V _{GS} =0V, f=1.0MHZ	--	1083	--	pF
Output Capacitance	C _{oss}		--	103	--	
Reverse Transfer Capacitance	C _{rss}		--	5.8	--	
Turn-on Delay Time	t _{d(on)}	V _{DD} =400V, I _D =8.0A, R _G =25Ω (Note 2,3)	--	30.33	--	ns
Turn-on Rise Time	t _r		--	67.0	--	
Turn-off Delay Time	t _{d(off)}		--	58.0	--	
Turn-off Fall Time	t _f		--	38.33	--	
Total Gate Charge	Q _g	V _{DS} =640V, I _D =8.0A, V _{GS} =10V (Note 2,3)	--	24.62	--	nC
Gate-Source Charge	Q _{gs}		--	7.26	--	
Gate-Drain Charge	Q _{gd}		--	8.97	--	

SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS

Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Continuous Source Current	I_S	Integral Reverse p-n Junction	--	--	8.0	A
Pulsed Source Current	I_{SM}	Diode in the MOSFET	--	--	32.0	
Diode Forward Voltage	V_{SD}	$I_S=8.0A, V_{GS}=0V$	--	--	1.4	V
Reverse Recovery Time	T_{rr}	$I_S=8.0A, V_{GS}=0V,$	--	310	--	ns
Reverse Recovery Charge	Q_{rr}	$di_F/dt=100A/\mu S$	--	0.53	--	μC

Notes:

1. $L=30mH, I_{AS}=5.50A, V_{DD}=135V, R_G=25\Omega$, starting $T_J=25^\circ C$;
2. Pulse Test: Pulse width $\leq 300\mu s$, Duty cycle $\leq 2\%$;
3. Essentially independent of operating temperature.

TYPICAL CHARACTERISTICS

Figure 1. On-Region Characteristics

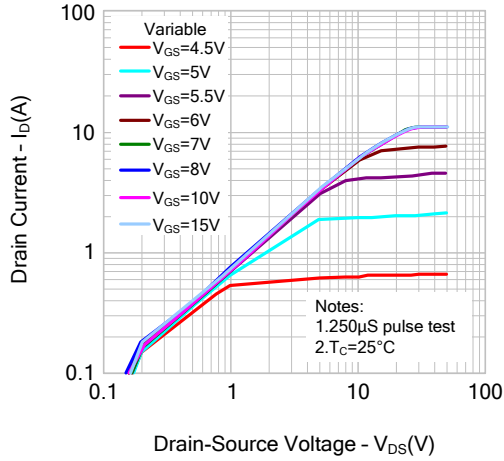


Figure 2. Transfer Characteristics

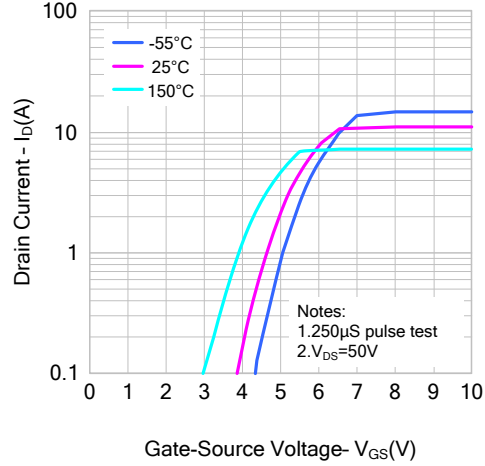


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

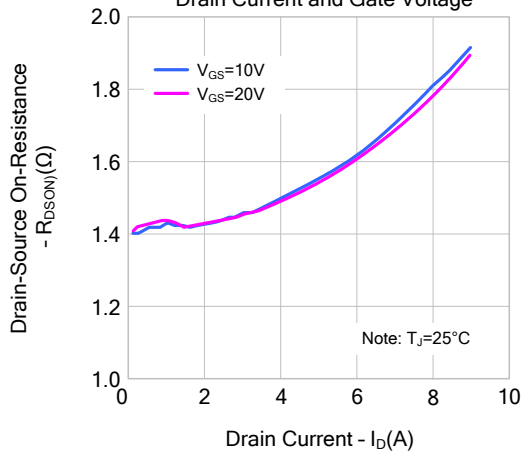


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

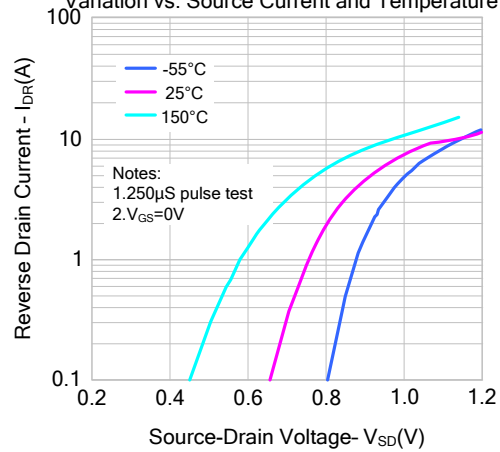


Figure 5. Capacitance Characteristics

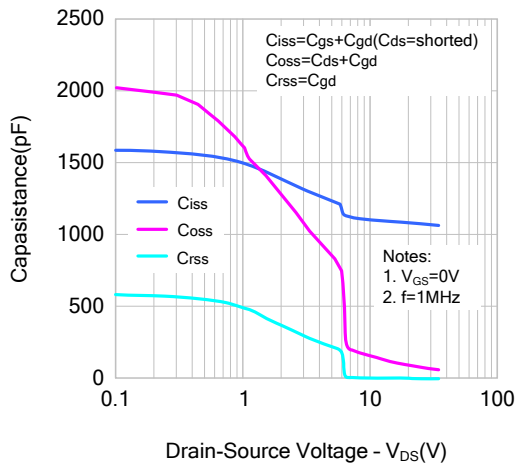
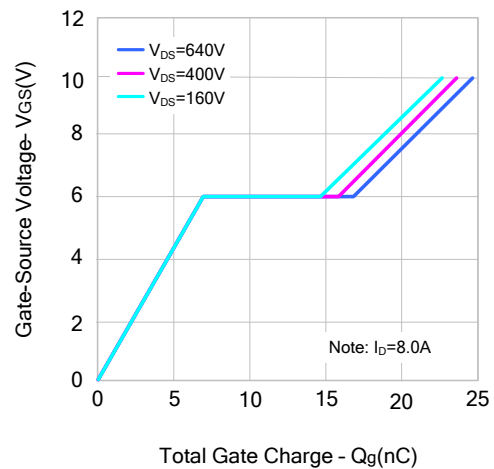


Figure 6. Gate Charge Characteristics



TYPICAL CHARACTERISTICS (CONTINUED)

Figure 7. Breakdown Voltage Variation vs. Temperature

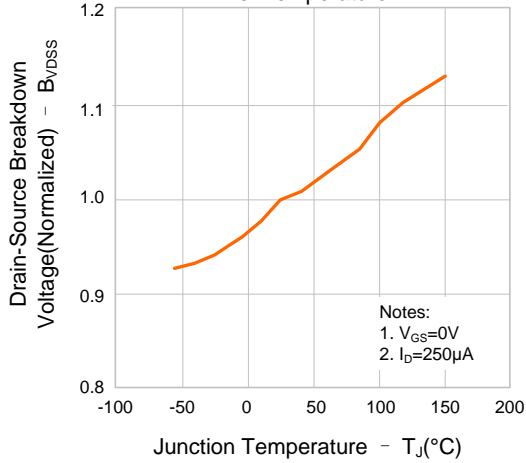


Figure 8. On-resistance Variation vs. Temperature

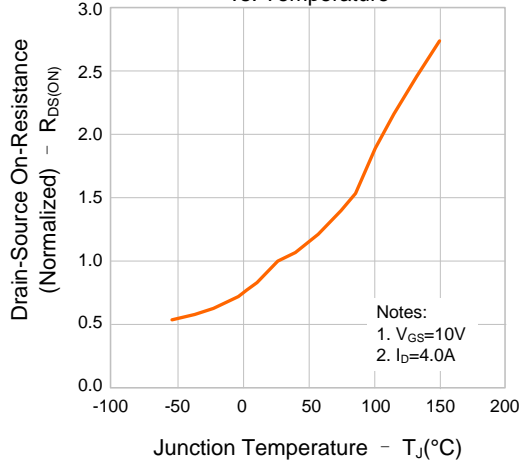


Figure 9-1. Max. Safe Operating Area(SVF8N80T)

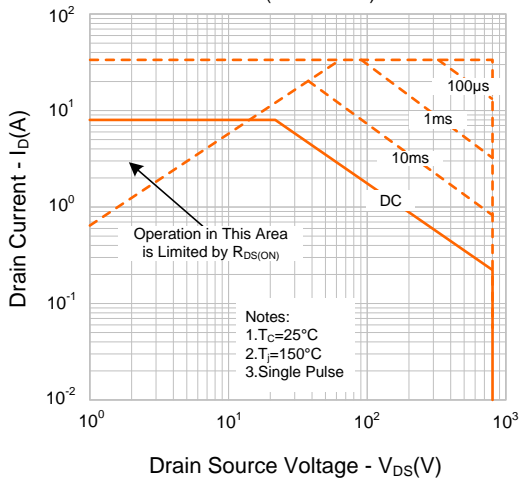


Figure 9-2. Max. Safe Operating Area(SVF8N80F)

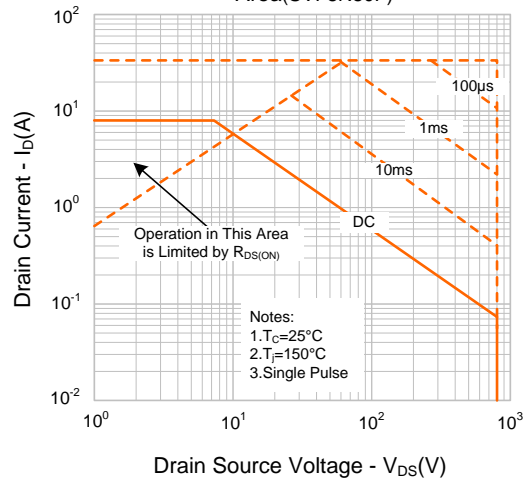


Figure 9-3. Max. Safe Operating Area(SVF8N80K)

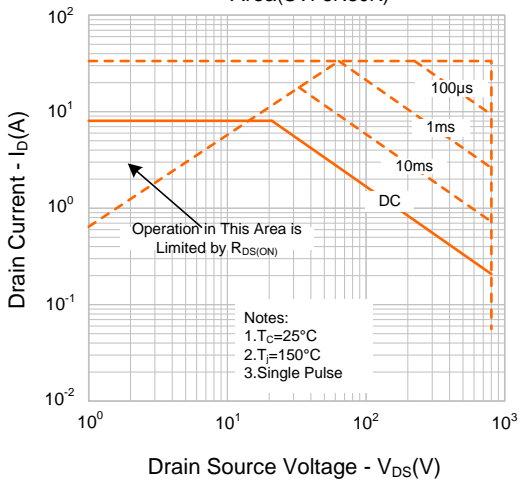
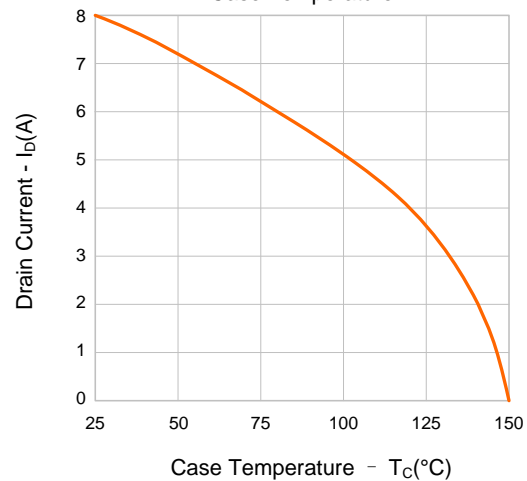
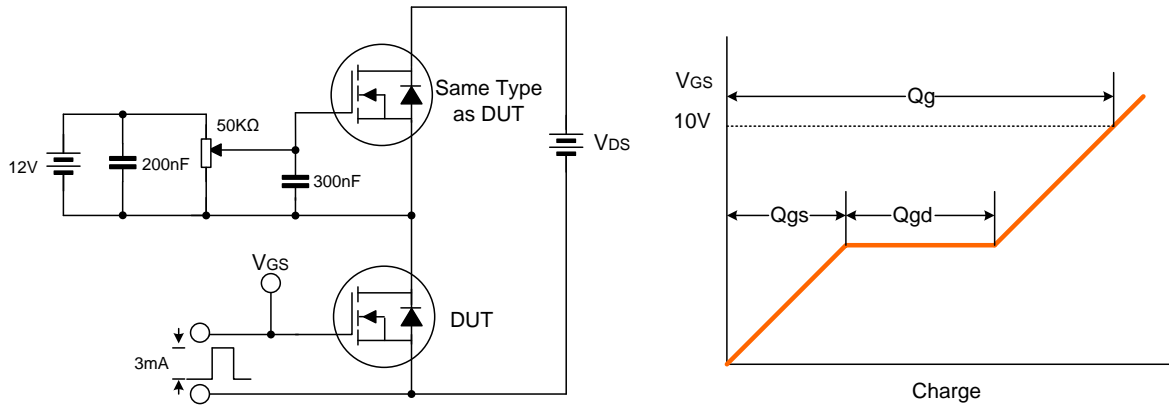


Figure 10. Maximum Drain Current vs. Case Temperature

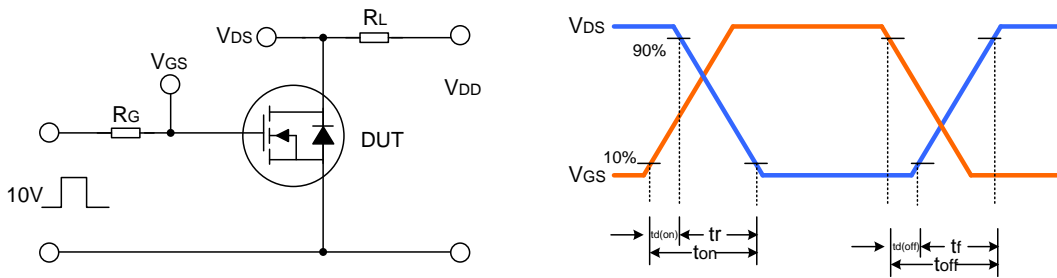


TYPICAL TEST CIRCUIT

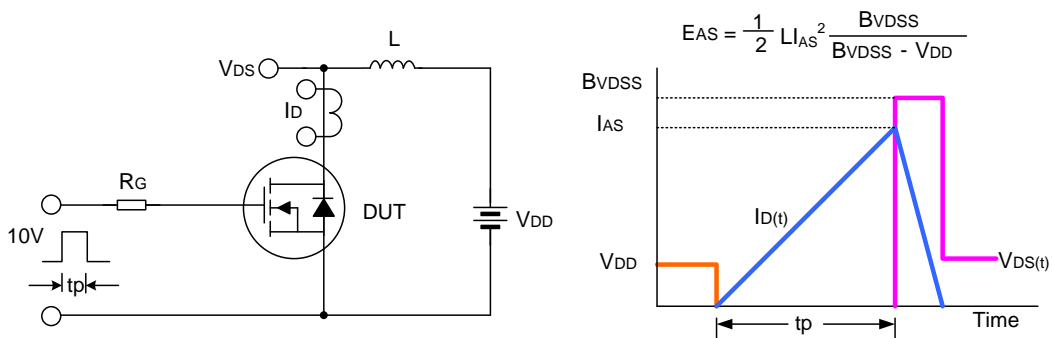
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveform



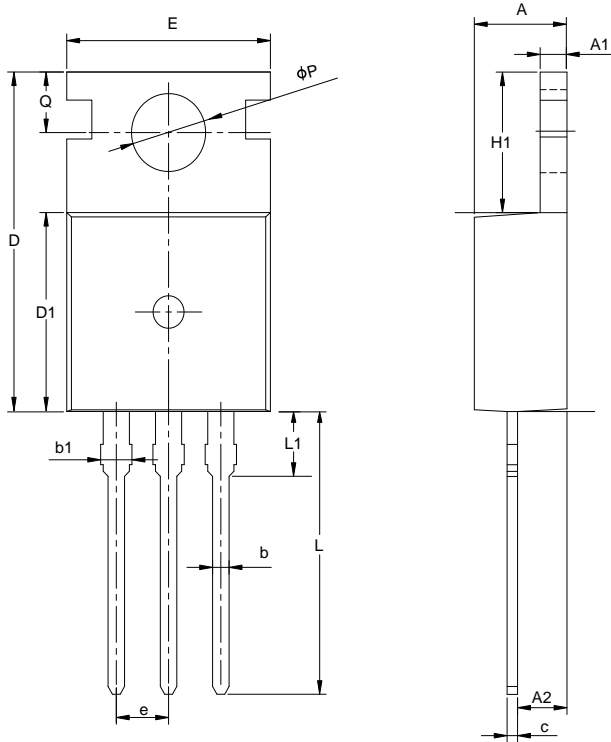
Unclamped Inductive Switching Test Circuit & Waveform



PACKAGE OUTLINE

TO-220-3L

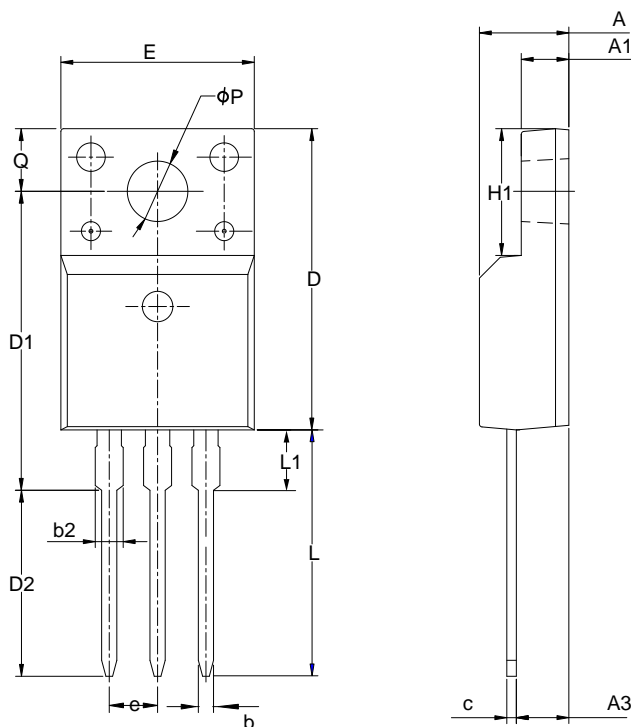
UNIT: mm



SYMBOL	MILLIMETER		
	MIN	NOM	MAX
A	4.30	4.50	4.70
A1	1.00	1.30	1.50
A2	1.80	2.40	2.80
b	0.60	0.80	1.00
b1	1.00	—	1.60
c	0.30	—	0.70
D	15.10	15.70	16.10
D1	8.10	9.20	10.00
E	9.60	9.90	10.40
e	2.54BSC		
H1	6.10	6.50	7.00
L	12.60	13.08	13.60
L1	—	—	3.95
ϕP	3.40	3.70	3.90
Q	2.60	—	3.20

TO-220F-3L

UNIT: mm

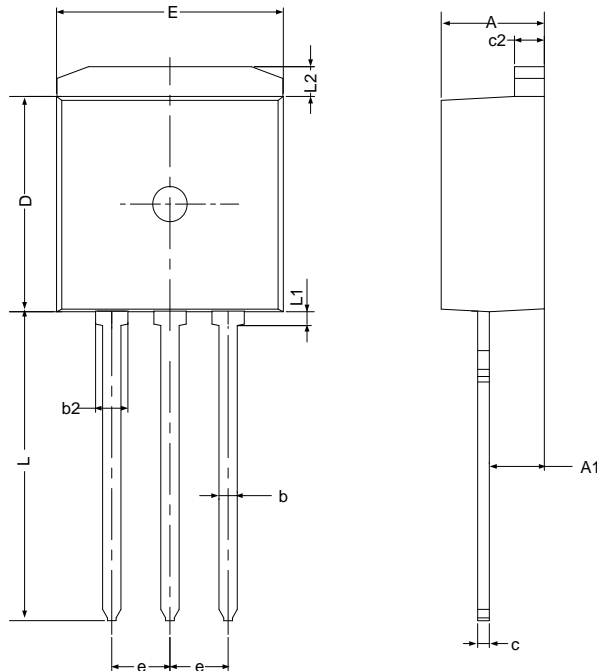


SYMBOL	MILLIMETER		
	MIN	NOM	MAX
A	4.42	4.70	5.02
A1	2.30	2.54	2.80
A3	2.50	2.76	3.10
b	0.70	0.80	0.90
b2	—	—	1.47
c	0.35	0.50	0.65
D	15.25	15.87	16.25
D1	15.30	15.75	16.30
D2	9.30	9.80	10.30
E	9.73	10.16	10.36
e	2.54BSC		
H1	6.40	6.68	7.00
L	12.48	12.98	13.48
L1	—	—	3.50
ϕP	3.00	3.18	3.40
Q	3.05	3.30	3.55

PACKAGE OUTLINE(CONTINUED)

TO-262-3L

UNIT: mm



SYMBOL	MILLIMETER		
	MIN	NOM	MAX
A	4.30	4.50	4.70
A1	2.20	—	2.92
b	0.71	0.80	0.90
b2	1.20	—	1.50
c	0.34	—	0.65
c2	1.22	1.30	1.35
D	8.38	—	9.30
E	9.80	10.16	10.54
e	2.54 BSC		
L	12.80	—	14.10
L1	—	—	0.75
L2	1.12	—	1.42

Important notice :

- The instructions are subject to change without notice! Customers should obtain the latest relevant information before placing orders and should verify that such information is complete and current.
- Our products are consumer electronic products, and / or civil electronic products.
- When using our products, please do not exceed the maximum rating of the products, otherwise the reliability of the whole machine will be affected. There is a certain possibility of failure or malfunction of any semiconductor product under specific conditions. The buyer is responsible for complying with safety standards and taking safety measures when using our products for system design, sample and whole machine manufacturing, so as to avoid potential failure risk that may cause personal injury or property loss.
- It is strongly recommended to identify the trademark when buying our products. Please contact us if there is any question.
- When exporting, using and reselling our products, buyer must comply with the international export control laws and regulations of China, the United States, the United Kingdom, the European Union and other countries & regions.
- Product promotion is endless, our company will wholeheartedly provide customers with better products!
- Website: <http://www.silan.com.cn>

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Rev.: 2.1

Revision History:

1. Deleted NOMENCLATURE
 2. Modify Important notice
 3. Modify the Hazardous Substance Control of SVF8N80K
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Rev.: 2.0

Revision History:

1. Modify the package outline of TO-262-3L
 2. Modify the ordering information
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Rev.: 1.9

Revision History:

1. Modify the package information of TO-220F-3L
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Rev.: 1.8

Revision History:

1. Modify the package information of TO-220F-3L
-

Rev.: 1.7

Revision History:

1. Add information for TO-262-3L package
-

Rev.: 1.6

Revision History:

1. Modify the ordering information
-

Rev.: 1.5

Revision History:

1. Modify the thermal characteristics
-

Rev.: 1.4

Revision History:

1. Modify the ordering information
-

Rev.: 1.3

Revision History:

1. Change the schematic diagram of MOS
-

Rev.: 1.2

Revision History:

1. Modify the max. value of Static Drain- Source On State Resistance
-

Rev.: 1.1

Revision History:

1. Modify "PACKAGE OUTLINE"
-

Rev.: 1.0

Revision History:

1. Initial release
